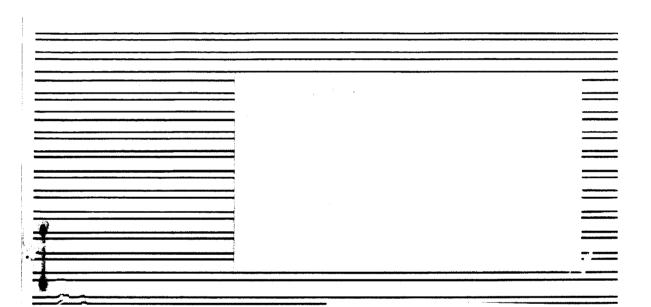
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UNITED STATES NAVAL AMMUNITION DEPOT
(CRANE, INDIANA)

EVALUATION PROGRAM
FOR
NICKEL CADMIUM SEALED CELLS :

GENERAL PERFORMANCE TEST OF GOULD-NATIONAL BATTERIES, INC. 3.5 AMPERE HOUR "D" CELLS

NASA CR 55631

QE/C 64-7) OTS!

2 January 1964

PREPARED UNDER THE DIRECTION OF

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Enclosure (1)

REPORT BRIEF

SEALED NICKEL CADMIUM BATTERY PROGRAM

OF

CELLS DESIGNED FOR USE IN SPACECRAFT

- Ref: (a) National Aeronautics and Space Administration Purchase Order Number W11,252B
 - (b) NASA ltr BRA/VBK/pad of 25 September 1961 w/BUWEPS first end FQ-1:WSK of 2 October 1961 to CO NAD Crane
 - (c) Preliminary Work Statement for Battery Evaluation Program of 25 August 1961
 - (d) National Aeronautics and Space Administration Preliminary Specification "Environmental Exposures and Tests for Subassemblies of International Ionosphere Satellite S-51" of 7 February 1961
 - (e) MIL-E-5272C(ASG) Amendment 1

I. TEST ASSIGNMENT BRIEF.

- A. In compliance with references (a) and (b), evaluation of Sealed Nickel Cadmium Cells was begun according to the program outline of reference (c). References (d) and (e) are Environmental Test Specifications.
- B. The object of this evaluation program is to gather specific information concerning sealed nickel cadmium cells designed for use in spacecraft. Information concerning the performance characteristics and limitations, including cycle life under various electrical and environmental conditions, will be of interest to power system designers and users. Cell weaknesses, including causes of failure of present designs, will be of interest to suppliers as a guide to product improvement.
- C. A total of 1100 cells was purchased by National Aeronautics and Space Administration (NASA) from four manufacturers, and consist of seven sample classifications ranging from 3 to 20 ampere hours.
- D. The program is divided into three main sections consisting of Acceptance Tests, General Performance Tests and Cycle Life Tests.
- E. This report is the first of a series of seven of the General Performance Test Section. It gives the results of the characterization tests of five "D" size cells supplied by Gould-National Batteries, Inc., St. Paul, Minnesota. These cells are rated at 3.5 ampere hours by the manufacturer.

II. SUMMARY OF RESULTS.

- A. The cells were capable of withstanding the Vibration, Mechanical Shock, and Acceleration requirements.
- B. Temperatures below and above 25° C. imposed the primary limitations on the charge acceptance and the discharge capacity of the cells.
- 1. At 25° C., the on charge voltage reached the maximum limit of 1.50 volts/cell at about 75 percent of the charging period at both the c/10 and c/5 rates. The discharge capacities measured at the c/5 or c/2 rates showed very little difference when previously charged at the c/10 or c/5 rates and compared favorable with those of the acceptance tests.
- 2. At 0° C., the on charge voltage reached the maximum limit of 1.50 volts/cell at about 50 percent of the charging period at both the c/10 and c/5 rates. The discharge capacities measured at the c/5 or c/2 rates showed very little difference when previously charged at the c/10 or c/5 rates. They were from 16 to 20 percent below the respective capacities measured at 25° C.
- 3. At 50° C., the on charge voltage never reached the maximum limit of 1.50 volts/cell. The discharge rate appeared to have a slight additional or secondary influence on the discharge capacity of the cells. The capacity of the cells, when discharged at c/5 and previously charged at either the c/10 or c/5 rates, was 47 to 50 percent of the respective capacities measured at 25° C. The capacity of the cells, however, when discharged at c/2 and previously charged at either the c/10 or c/5 rates was only about 43 percent of the respective capacities measured at 25° C.
- C. The cells, at 0° C., were incapable of accepting a continuous overcharge at a rate of c/10 or higher as the maximum on charge voltage limit of 1.55 volts/cell was reached prematurely. Indications are that at 25° C. and at 50° C., the cells are capable of withstanding overcharges as high as the c/2 charge rate. The overcharge at the c/2 rate was accomplished during the overcharge sequence which began with the c/10 rate and was increased by steps to the c/1 rate, after stabilization of voltage at each preceding charge rate. It is questionable if the cells could have been overcharged at the c/2 rate when applied initially to a fully charged cell, without reaching the maximum voltage limit of 1.55 volts per cell before voltage stabilization.
 - D. Charging efficiency was limited by temperature.
- 1. At 0° C., the voltage limit of 1.50 volts/cell was reached at each charge rate before the cells reached 100 percent charge, thereby, limiting the charge acceptance and the discharge capacity.

- 2. At 25° C., the voltage limit was reached only at the c/1 rate. At the c/24, c/16, and c/10 charging rates, the maximum discharge capacity was reached at approximately 125 percent of the rated capacity recharge. The maximum capacity at all charging rates ranged from 97 to 108 percent of the actual capacity of the cell as found in the acceptance tests.
- 3. At 50° C., the voltage limit was reached on only one of the two cells at the c/l charge rate. The inefficiency of the charge acceptance at 50° C. at the c/24, c/16 and c/10 charge rates allowed a maximum discharge cpacity of 42 to 52 percent of the acceptance test capacities. The maximum capacities of cells charged at the c/5 rate with 300 percent recharge was approximately 60 percent of the acceptance test capacities. and that of cells charged at c/l rate with 700 percent recharge was approximately 87 percent of the acceptance test capacities.

RESULTS OF GENERAL PERFORMANCE TESTS

OF

3.5 AMPERE HOUR SEALED NICKEL CADMIUM CELLS

MANUFACTURED BY

GOULD-NATIONAL BATTERIES, INC.

I. INTRODUCTION.

- A. On 6 May 1963, this activity began the General Performance Tests on five cells, following completion of the acceptance tests of the 200 cells. The general performance tests were completed on 25 September 1963.
- B. The five cells chosen for the general performance tests consisted of two with actual capacities above the average of the 200 accepted cells, one with capacity approximately equal to the average, and two with capacities below the average.

II. TEST CONDITIONS.

- A. The general performance or characterization tests were performed at existing relative humidity and atmospheric pressure and at three specific temperatures. The tests and test temperatures were as follows:
 - 1. Vibration Test at room ambient temperature.
 - Mechanical Shock Test at room ambient temperature.
 - 3. Acceleration Test at room ambient temperature.
- 4. Charge and Discharge Voltage versus Time at 0° C., 25° C., and 50° C.
 - 5. Overcharge Characteristics at 0° C., 25° C., and 50° C.
 - 6. Charging Efficiency at 0° C., 25° C., and 50° C.
- B. All charging was by modified constant current with a voltage limit. All discharges were constant current.

III. CELL IDENTIFICATION AND DESCRIPTION.

A. The five cells used for these tests were picked from the 200 cells in the acceptance test section. The capacity of cells 123 and 160 was above the average of the 200 cells, cell RRR38 approximated the average capacity, and cells 17 and 76 were below the average capacity.

- B. The 3.5 ampere hour "D" cell is cylindrical with an average diameter of 1.279 inches and an average over-all length of 2.221 inches exclusive of the negative terminal seal. The average weight of the 200 cells was 135.2 grams.
- C. The cell container or can, and the cell cover are made of stainless steel and serve as the positive terminal. The negative terminal is a pigtail type extension of the negative plate tab through the center of the cover. The negative terminal is insulated from the "positive" cover by a glass to metal seal.

IV. TEST PROCEDURES AND RESULTS.

A. Sinusoidal Vibration Test.

- l. Each cell, fully charged, was individually mounted in a rigid test fixture attached to the table of a M. B. Electronics Model C-10 vibrator. The amplitude or acceleration was monitored on the test fixture near the mounting points.
- 2. Each cell in turn, was then subjected to the sinusoidal vibration test conditions given in paragraph 3.2.4.1.2.1 of reference (d), which stated that the applied frequency shall be swept from the lowest to the highest frequency, once for each range and for each axis specified in the following schedule.

SINUSOIDAL SWEEP SCHEDULE

Frequency Range - cps	Test Time Minutes	Acceleration g, 0 - to - Peak
10 - 50	1.6 6	2.3 (a)
50 - 500	1.66	10.7
500 - 2000	1.00	21.0
2000 - 3000	0.30	54.0
3000 - 4500	0.36	21.0 (ъ)
	5.00 Min. Each Axis	•

- NOTES: (a) Within maximum amplitude limit of vibration exciter.
 - (b) Within maximum frequency limit of vibration exciter.
- 3. During the applied vibration, the cells were discharged at a rate of c/5 amperes. The discharge current and terminal voltage were

monitored for evidence of cell malfunction during applied vibration.

After the vibration test, the cells were visually examined for evidence of mechanical damage and checked by litmus paper for electrolyte leakage.

B. Random Motion Vibration.

1. Following the sinusoidal vibration, each cell was subjected to gaussian random vibration applied to each axis with the "g-peaks" clipped at three times the root-mean-square acceleration specified in the schedule. The vibration was applied successively to the Z-Z, X-X, and Y-Y axes. With the cell installed, the control accelerometer response was equalized with peak-notch filterization such that the specified power spectral density (PSD) values were within ± 3 db throughout the frequency band.

RANDOM VIBRATION SCHEDULE

Frequency Test Range Duration cps Minutes		PSD Level g ² /cps	Approximate Acceleration g-rms	
20 - 2000	4 Each Axis	0.07	11.5 (a)	

NOTE: (a) Within amplitude limit of vibration exciter.

2. There were no failures of the five cells subjected to the vibration tests.

C. Mechanical Shock Test.

- 1. Each cell was charged at c/10 rate for 16 hours following the vibration test.
- 2. Each fully charged cell was mounted in a rigid test fixture. The fixture and the cells were mounted on the Barry Type 16805 Shock Machine. Each cell was subjected to 18 impact shocks as outlined in Procedure V, paragraph 4.15.5.1 of Specification MIL-E-5272C(ASG), reference (e), except that 40 G (for 11 ± 1 milliseconds) was used in lieu of 15 G. Three shocks were applied in each direction of each of the three mutually perpendicular axes of the cells.
- 3. During the shock test, the cells were discharged at a rate of c/5 amperes. The discharge current and terminal voltage were monitored at the moment of impact for evidence of malfunction of any cells.
- 4. At the conclusion of the test, the cells were examined for mechanical damage and checked with litmus paper for electrolyte leakage.

5. There were no failures of the five cells subjected to the mechanical shock tests.

D. Acceleration Test.

- 1. Each cell was charged at c/10 rate for 16 hours following the mechanical shock test.
- 2. Each fully charged cell was mounted in a rigid fixture and attached to the Genisco Model C-159 Centrifuge. The cell was then subjected to the acceleration test conditions specified in paragraph 3.2.5.1.2 of reference (d). Accelerations were in the order listed below:

Axis Direction	Acceleration Gravity Units (G)	Duration <u>Minutes</u>		
+Z	28.0	5.0		
±Y +X	4.0	3.0		
-X	12.0	0.5		

- 3. During the acceleration tests, the cells were discharged at a rate of c/5 amperes. The discharge current and terminal voltage were monitored for evidence of cell malfunction during the acceleration test periods.
- 4. At the conclusion of the tests, the cells were examined for mechanical damage and checked with litmus paper for electrolyte leakage.
- 5. One cell was rejected due to erratic voltage and a low voltage characteristic under load during acceleration. The cell was opened under the direction of Gould-National Batteries, Inc. representative, Mr. James Gilchrist. The weld of the positive tab to the base of the can was found to be loosened. This was the result of an insufficient weld that had probably partially severed during mechanical shock. The recharge prior to the acceleration test had oxidized the tab causing a high resistance contact. The stress of acceleration had caused the erratic and low voltage under load.

E. Charge and Discharge Voltage Versus Time.

- 1. The five cells, each with a thermocouple attached to the positive terminal (cover surface), were place in a temperature chamber and allowed to stabilize at 0° C.
- 2. The five cells were subjected to the charge and discharge sequence listed below:

Charge	Discharge	No. of Cycles	Temperature	Data		Charge Voltage	
c/10 - 16 Hrs	c/5 to 0.9 Volts	5##	0° C.	Voltage	Time	Cell* Temp.	Limited to 1.5 V/Cell
c/10 - 16 Hrs	c/2 to 0.9 V olts	2	0° C.	Voltage	Time	Cell* Temp.	Limited to 1.5 V/Cell
c/5 - 8 Hrs	c/5 to 0.9 Volts	2	0° C.	Voltage	Time (Cell* Temp.	Limited to 1.5 V/Cell
c/5 - 8 Hrs	c/2 to 0.9 V olts	2	0° C.	Voltage	Time	Cell* Temp.	Limited to 1.5 V/Cell

^{*} Cell temperature measured by thermocouple.

- 3. Upon completion of the above sequence, the tests were repeated for 25° C. and 50° C. ambient temperature conditions.
- 4. The results are shown graphically with cell charge and discharge voltages versus time as a function of rate of charge, rate of discharge and ambient temperature on Figures 1 through 20. Figure 21 is a graphic summary of the data of Figures 1 through 20.
 - 5. There were no cell failures during any portion of these tests.

F. Overcharge Characteristics.

- 1. The five discharged cells were allowed to stabilize at 0° C. The cells were then subjected to the overcharge sequence listed below:
 - a. Charge at c/10 for 16 hours.
 - b. Charge at c/10 until the cell voltage stabilizes.
 - c. Charge at c/8 until the cell voltage stabilizes.
 - d. Charge at c/6 until the cell voltage stabilizes.
 - e. Charge at c/4 until the cell voltage stabilizes.
 - f. Charge at c/2 until the cell voltage stabilizes.
 - g. Charge at c/l until the cell voltage stabilizes.

^{**} Each cell was subjected to two or more charge-discharge cycles, until repeatability of data was satisfactory.

- 2. Upon completion of the above sequence, the tests were repeated for 25° C. and 50° C. ambient temperature conditions.
- 3. On all tests, the voltage limit was 1.55 volts per cell and the cell temperature limit was 77° C. Exceeding either limit terminated the test at that temperature.
- 4. Table I shows the cell temperature as compared to the ambient temperature at the voltage stabilization point of each charging rate. Where "voltage limited" is noted, the cell voltages increased to the limiting value of 1.55 volts at the c/10 charging rate without reaching a stabilization point. Where 77° C. was exceeded at the c/1 charging rate, the temperature had increased rapidly during the first hour and then stabilized at the higher temperature which was not indicative of thermal runaway.
- 5. The results are shown graphically on Figure 22 as a plot of the cell voltage versus the log of the charging current.
- 6. Although the 0° C. sequence was terminated by the 1.55 volts per cell limit at the c/10 rate, there were no cell failures on any portion of these tests.

G. Charging Efficiency.

- 1. At the completion of the overcharge characteristics sequence, the cells were discharged at the c/2 rate to 1.0 volt per cell.
 - 2. The five cells were then divided into three groups as follows:
- a. One group of two cells (one above average and one below average) to be tested at 0° C. \pm 2° C.
- b. One group of one cell (average cell) to be tested at 25° C. ± 2° C.
- c. One group of two cells (one above average and one below average) to be tested at 50° C. ± 2° C.
- 3. At each temperature, the charging efficiencies of each of the five charging rates; c/10, c/24, c/16, c/5 and c/1; were determined by a series of charges at each given rate at designated increased time periods followed by discharges to 1.0 volts per cell until the charge ampere hours versus the discharge ampere hours indicated the "knee" had been reached and verified as shown in Figures 23 through 27. The duration of the initial charge at each rate was one-half of the number of hours required for 100 percent charge.

- 4. A normalizing cycle consisting of a c/5 charge for 8 hours and a c/2 discharge to 1.0 volt was given all cells after each set of charge rate tests before proceeding to the next series.
 - 5. A sample run for the c/10 charging rate was as follows:
 - a. Recharged at c/10 for 5 hours. Discharged at c/2 to 1.0 volt.
 - b. Recharged at c/10 for 6 hours. Discharged at c/2 to 1.0 volt.
 - c. Recharged at c/10 for 7 hours. Discharged at c/2 to 1.0 volt.
 - d. Recharged at c/10 for "X" hours. Discharged at c/2 to 1.0 volt.

NOTE: X = number of hours necessary to indicate that the "Knee" of the Charge Ampere Hours versus Discharge Ampere Hours has been reached.

APPENDIX

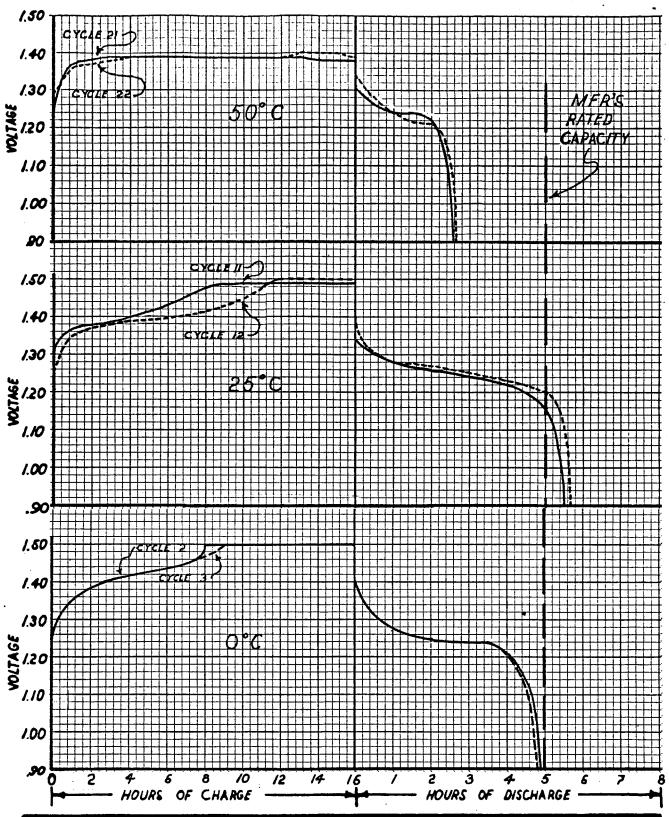
I. Table I shows the cell temperatures as compared to the ambient temperatures at the stabilizing point of each charging rate.

II. FIGURES.

- A. Figures 1 through 20 are graphs showing charge and discharge voltages versus time as a function of rate of charge, rate of discharge and ambient temperature.
- B. Figure 21 is a graphic summary of the data of Figures 1 through 20.
 - C. Figure 22 is a graph showing overcharge characteristics.
- D. Figures 23 through 27 are graphs showing the charging efficiencies as a plot of charging ampere hours versus discharging ampere hours.

TABLE I

		Stabilizing Temperature (* C.)					
Cell Number	Ambient Temperature	c/10 Charge	c/8 Charge	c/6 Charge	C/4	c/2	c/l
MONTO 47	1 ember e our e	oner Re	on err.Re.	ouar.Ra	Charge	Charge	Charge
RRR38	0° C.			VOLTAGE	LIMITED		
17	0° C.			VOLTAGE	LIMI TED		
76	0° C.			VOLTAGE	LIMITED		
123	0° C.		-	VOL TAGE	LIMITED		
160	0° C.			VOL TAGE	LIMITED		
	·						
RRR38	25° C.	25.0	27.8	29.4	33.9	42.2	56.1
17	25° C.	25.0	28.9	30.6	33.3	37.8	46.7
76	25° C.	25.0	29.4	31.1	31.7	36.7	45.6
123	25° C.			VOLTAGE	LIMITED		
160	25° C.	25.0	29.4	31.7	30.6	34.4	42.8
				•	•		
RRR38	50° C.	5 2. 8	53.9	55.0	57.2	60.0	72.2
17	50° C.	53.3	54 -4	55.6	57.8	61.7	76.7
76	50° C.	53.3	54.4	55.6	57.8	63.3	80.0
123	50° C.	53.3	54.4	55.6	58.9	63.9	82.2
160	50° C.	53.9	55.0	56.7	58.9	63.9	84.4

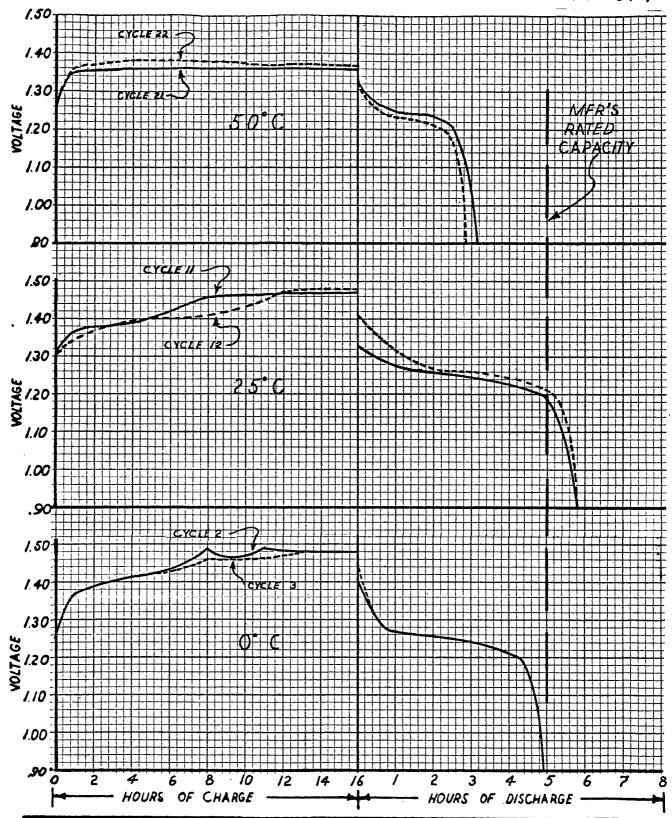


GOULD D-CELL NO. 17

NAD CRANE CAPACITY 3.48 A.H.

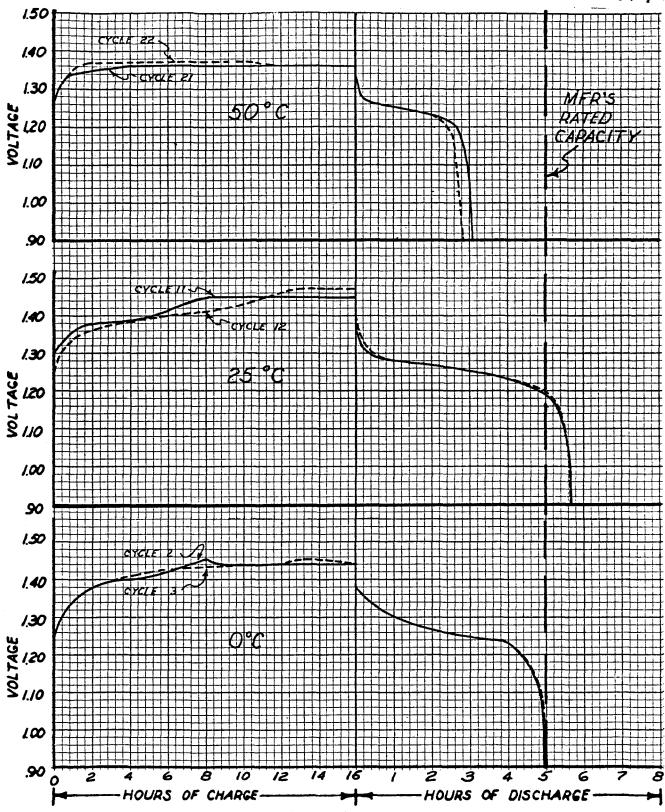
CHARGE CURRENT .35 A. (%/10), VOLTAGE LIMITED TO 1.60 V. MER CELL

DISCHARGE CURRENT .70 A. (%/5), CUTOFF VOLTAGE 0.9 V.

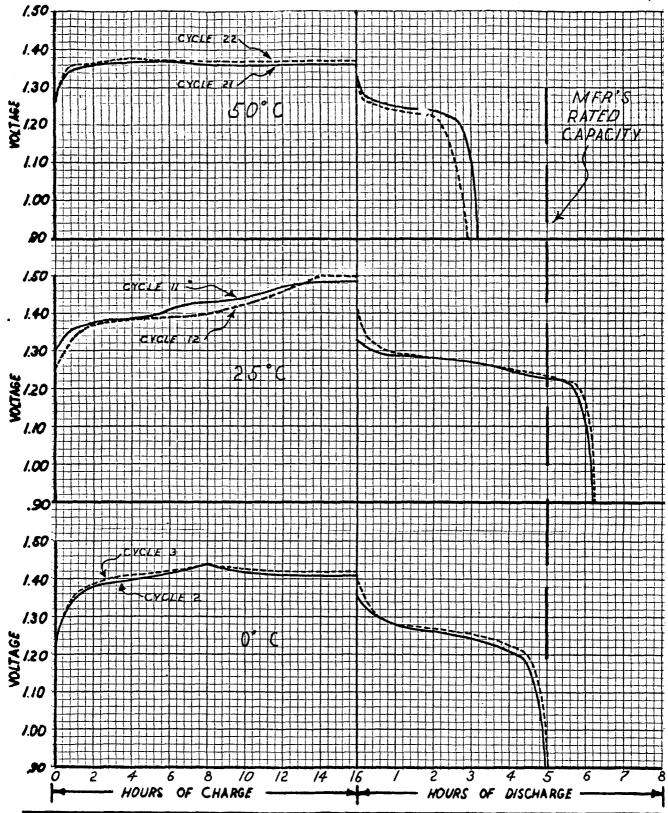


GOULD D-CELL NO. 76 NAD CRANE CAPACITY 3.50 A.H. CHARGE CURRENT .35 A. (°/10), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT .70 A. (°/5), CUTOFF VOLTAGE 0.9 V.

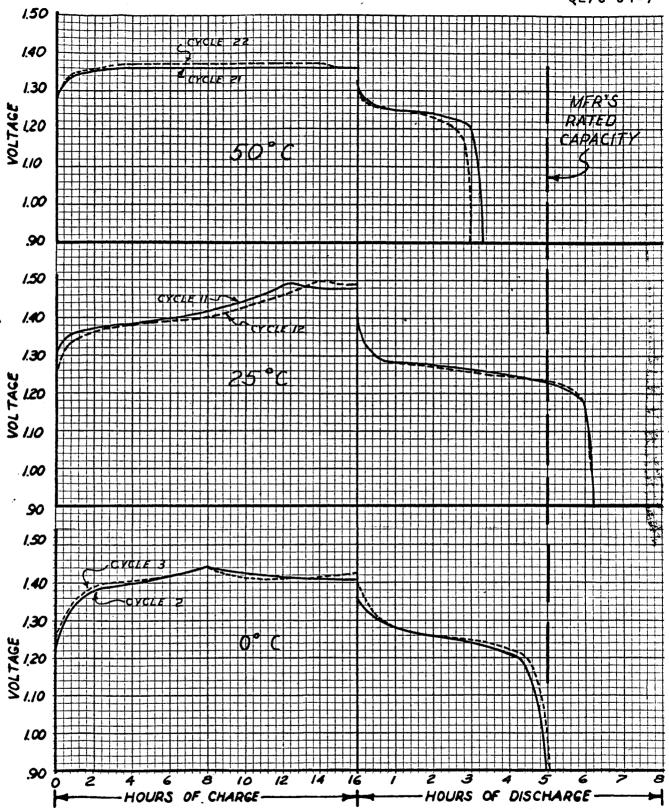




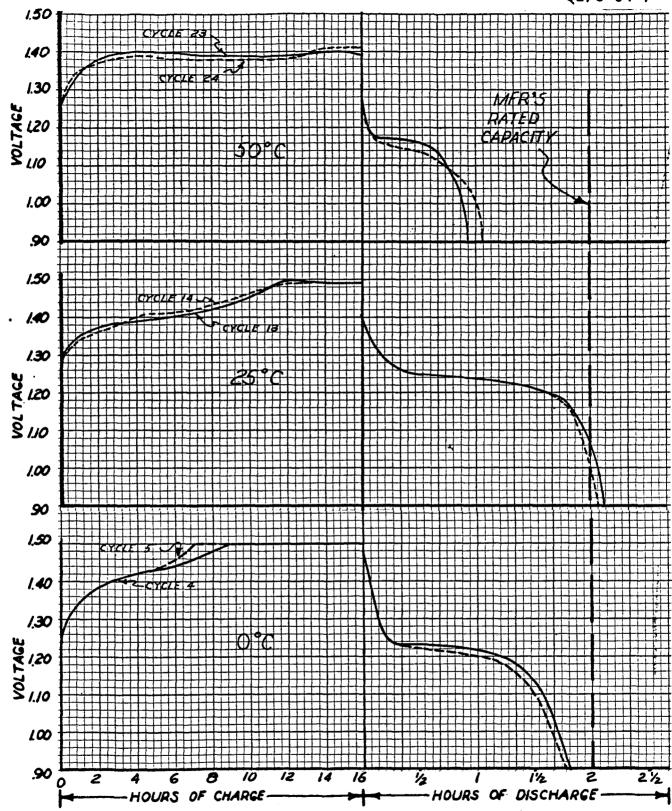
GOULD D-CELL NO. RRR 38 NAD CRANE CAPACITY 3.80 A. H. CHARGE CURRENT .35 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT .70 A. (%), CUTOFF VOLTAGE 0.9 V.



GOULD D-CELL NO. 123 NAD CRANE CAPACITY 4.42 A.H. CHARGE CURRENT .35 A. (6/10), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT .70 A. (4/5), CUTOFF VOLTAGE 0.9 V.

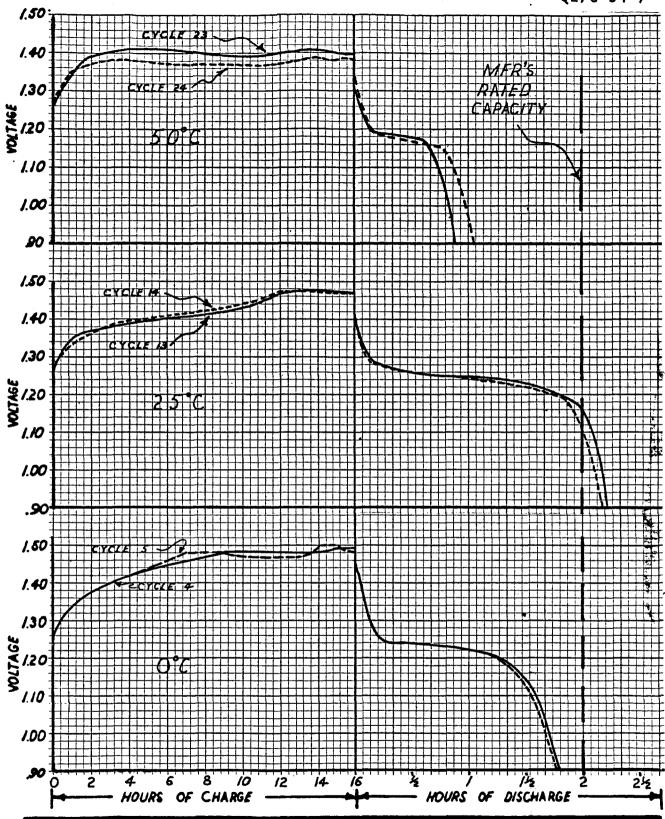


GOULD D-CELL NO. 160 NAD CRANE CAPACITY 4.34 A.H. CHARGE CURRENT .35 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT .70 A. (%5), CUTOFF VOLTAGE 0.9 V.



GOULD D- CELL NO. 17 NAD CRANE CAPACITY 3.48 A. H. CHARGE CURRENT .35 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT 1.75 A. (%), CUTOFF VOLTAGE 0.9 V.

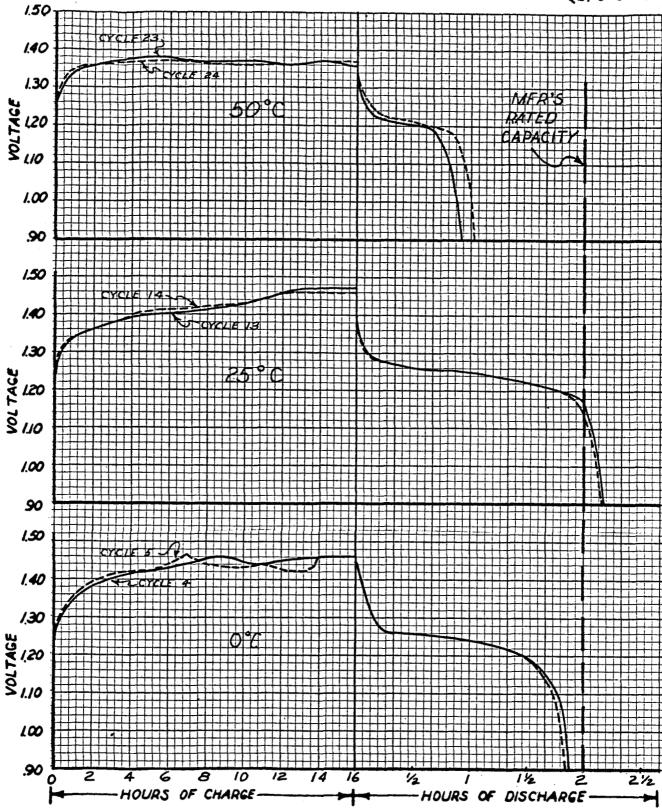




GOULD D-CELL NO. 76

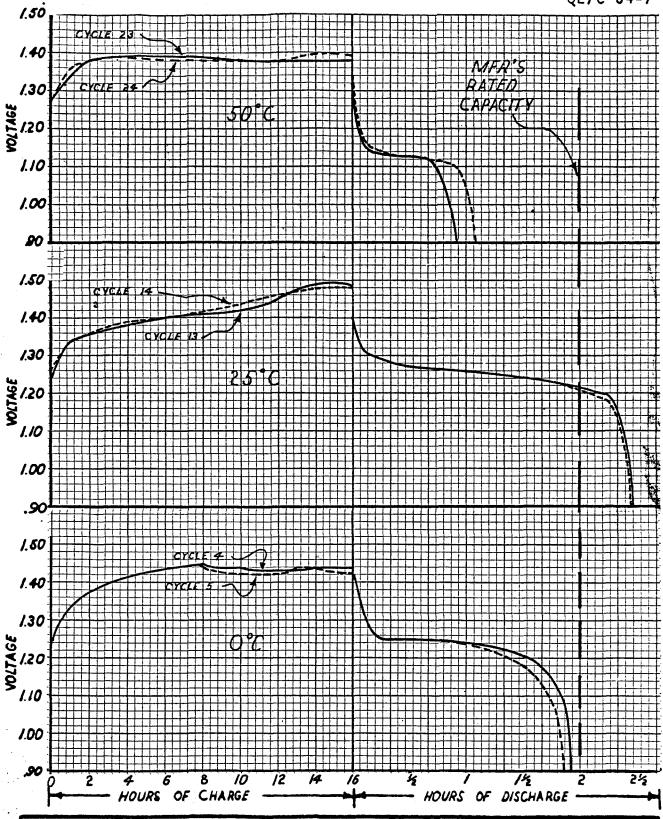
NAD CRAME CAPACITY 3.50 A.H. CHARGE CURRENT .35 A. (%/10), VOLTAGE LIMITED TO LEO V. MER CELL DISCHARGE CURRENT 1.75 A. (%/2), CUTOFF VOLTAGE 0.9 V.



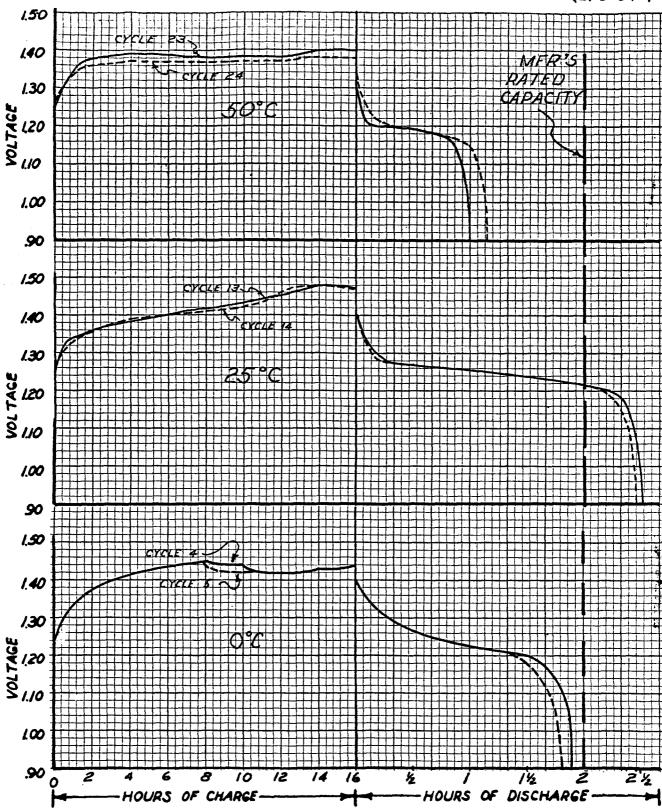


GOULD D-CELL NO. RRR38 NAD CRANE CAPACITY 380 A.H. CHARGE CURRENT .35 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT 1.75 A. (%), CUTOFF VOLTAGE 0.9 V.



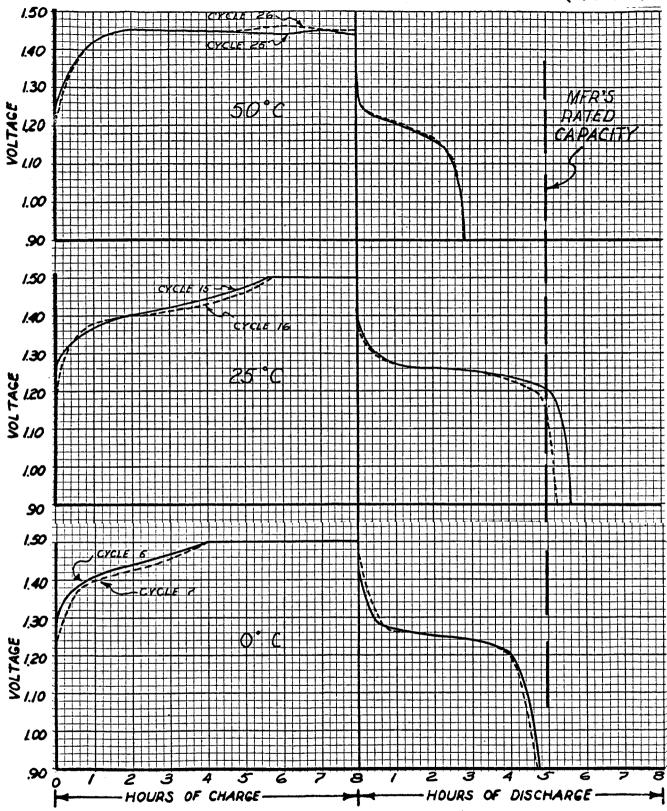


GOULD D-CELL No. 123 NAD CRANE CAPACITY 4.42 A.H. CHARGE CURRENT .35 A. (6/10), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT 1.75 A. (6/2), CUTOFF VOLTAGE 0.9 V.



GOULD D- CELL NO. 160 NAD CRAME CAPACITY 4,34 A.H. CHARGE CURRENT .35 A. (%), VOLTAGE LIMITED TO 160 V. PER CELL DISCHARGE CURRENT 1.75 A. (%2), CUTOFF VOLTAGE 0.9 V.

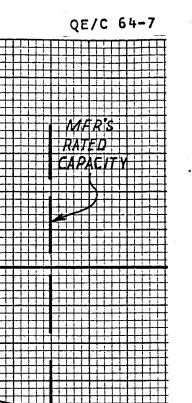


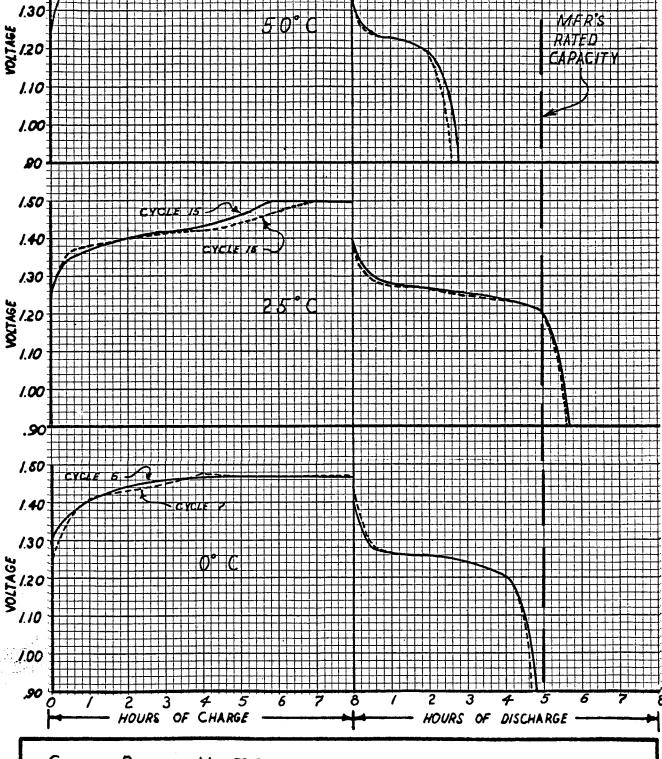


GOULD D-CELL NO. 17 NAD CRANE CAPACITY 3.48 A.H.

CHARGE CURRENT .70 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL

DISCHARGE CURRENT .70 A. (%), CUTOFF VOLTAGE 0.9 V.

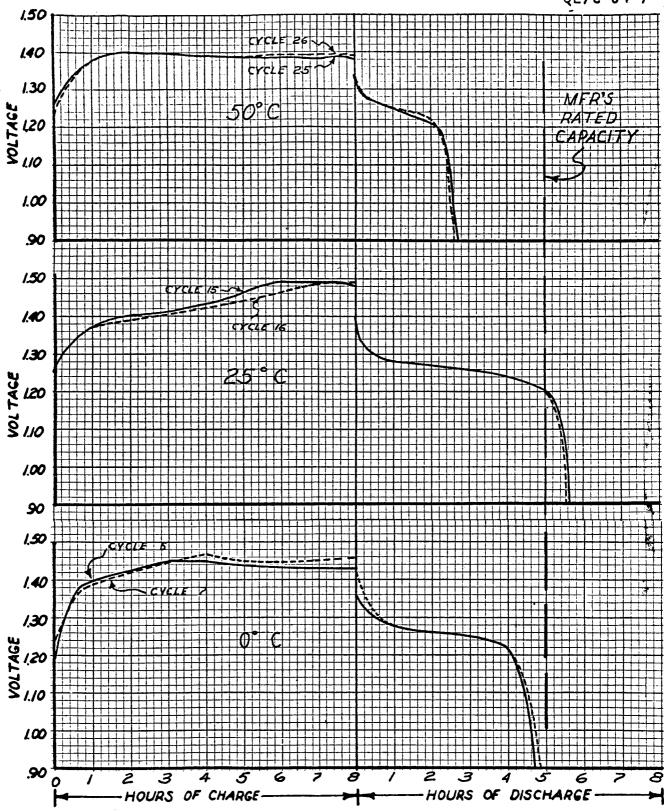




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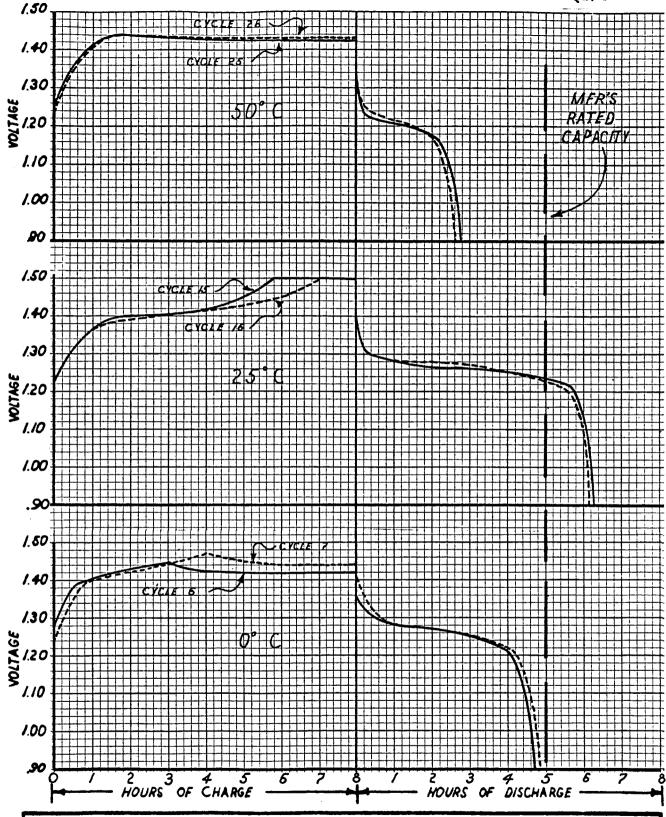
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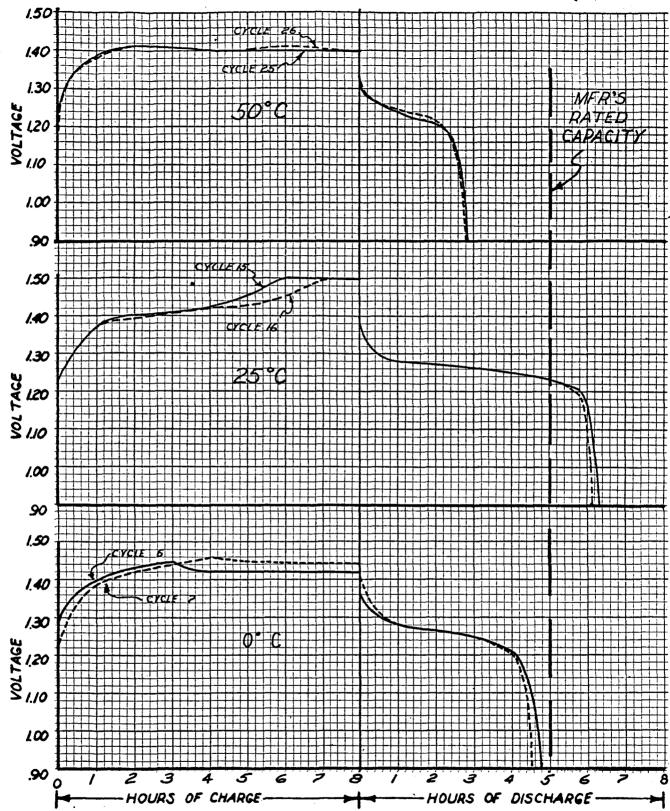


GOULD D-CELL NO. RRR 38 NAD CRANE CAPACITY 3.80 A.H. CHARGE CURRENT .70 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT .70 A. (%), CUTOFF VOLTAGE 0.9 V.



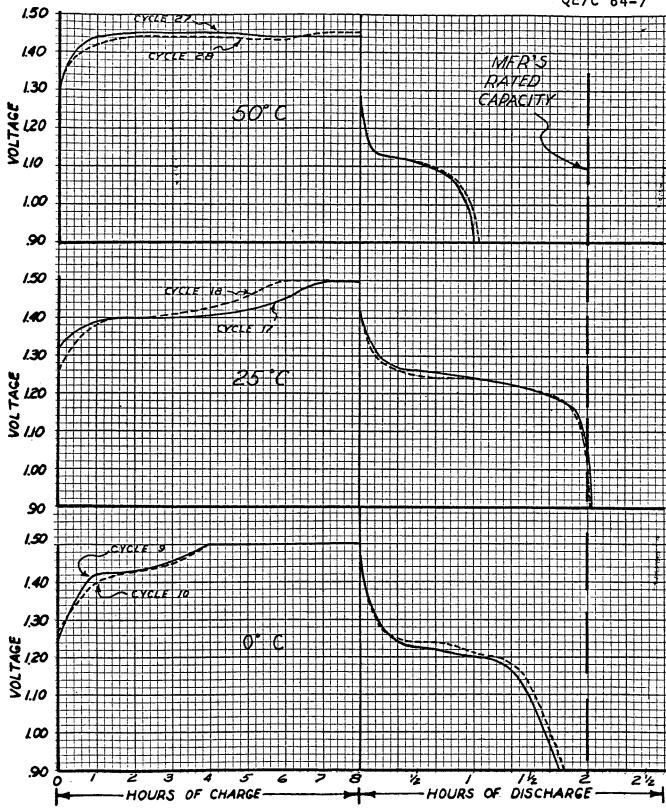


GOULD D-CELL No. 123 NAD CRANE CAPACITY 4.42 A.H. CHARGE CURRENT .70 A. (°/5), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT .70 A. (°/5), CUTOFF VOLTAGE 0.9 V.



GOULD D-CELL NO. 160 NAD CRANE CAPACITY 4.34 A.H. CHARGE CURRENT .70 A. (%5). VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT .70 A. (%5), CUTOFF VOLTAGE 0.9 V.

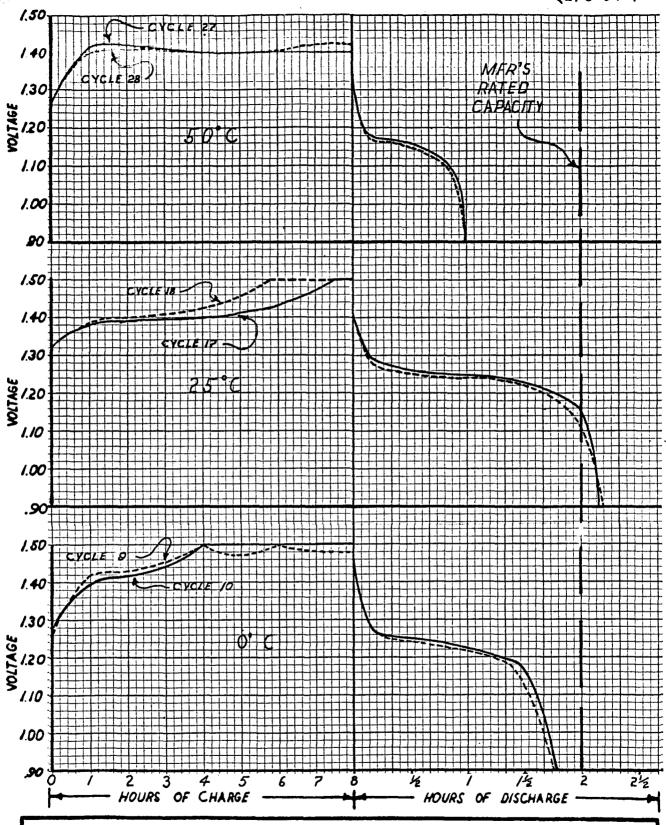




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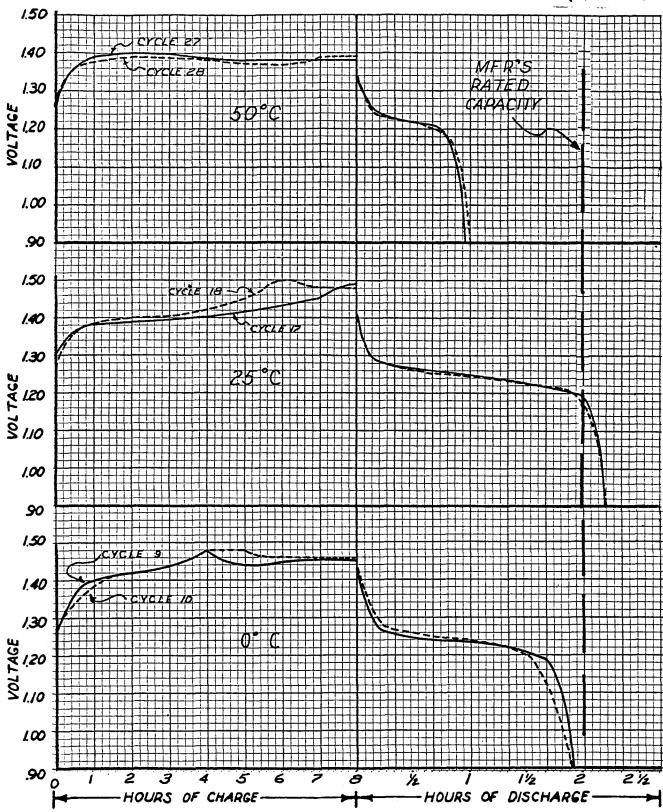
CHARGE CURRENT .70 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL

DISCHARGE CURRENT 1.75 A. (%), CUTOFF VOLTAGE 0.9 V.



GOULD D-CELL NO. 76

NAD CRANE CAPACITY 3.50 A.H. CHARGE CURRENT .70 A. (°/5), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT 1.75 A. (°/2), CUTOFF VOLTAGE 0.9 V.

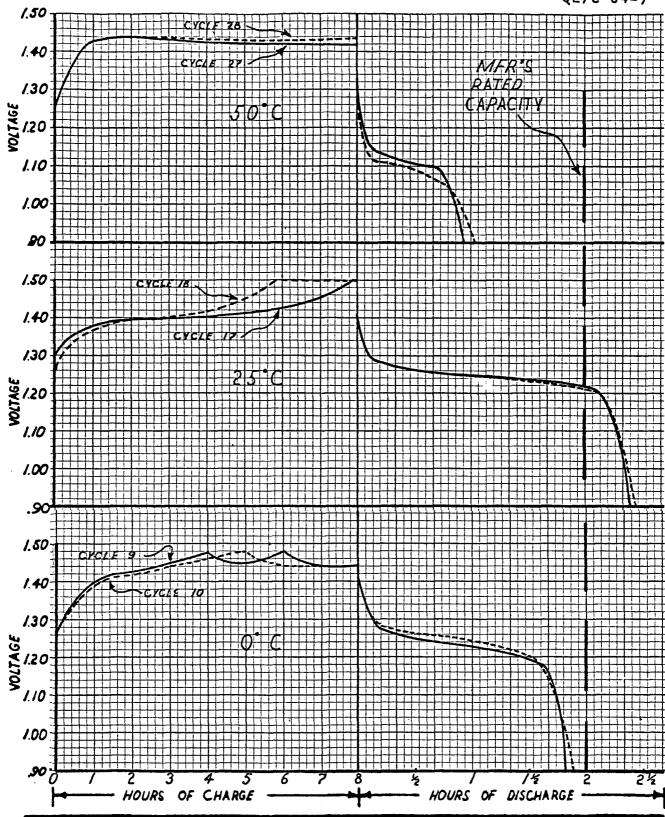


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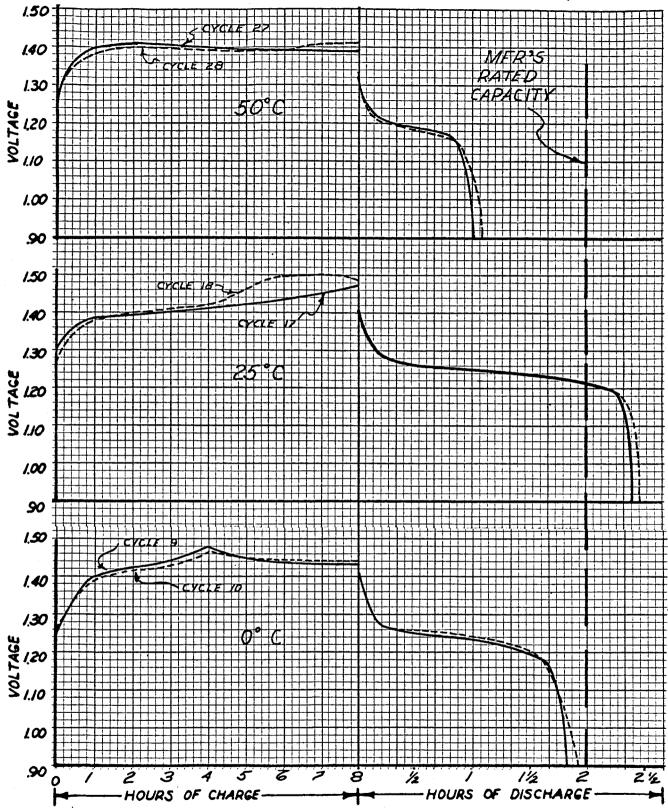
CHARGE CURRENT .70 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL

DISCHARGE CURRENT 1.75 A. (%), CUTOFF VOLTAGE 0.9 V.

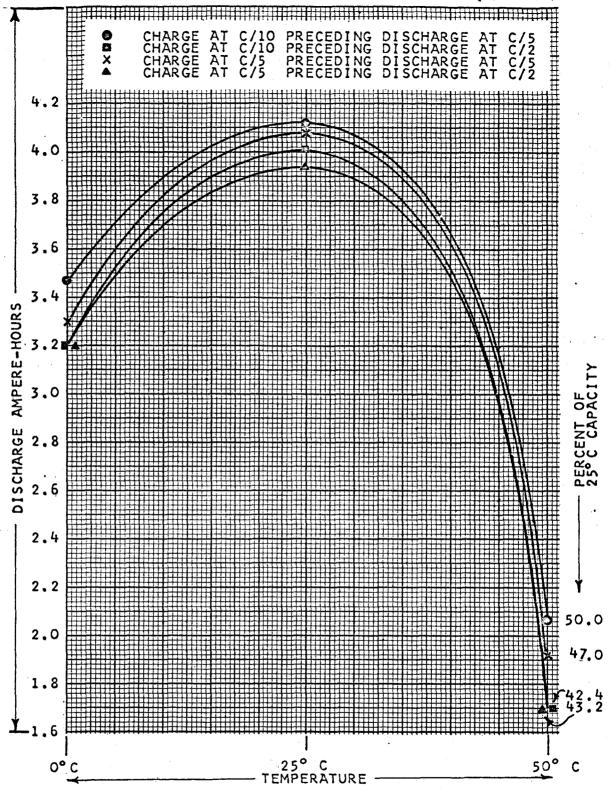




GOULD D-CELL NO. 123 NAD CRANE CAPACITY 4.42 A.H. CHARGE CURRENT .70 A. (6/5), VOLTAGE LIMITED TO 1.50 V. PER CELL DISCHARGE CURRENT 1.75 A. (6/2), CUTOFF VOLTAGE 0.9 V.



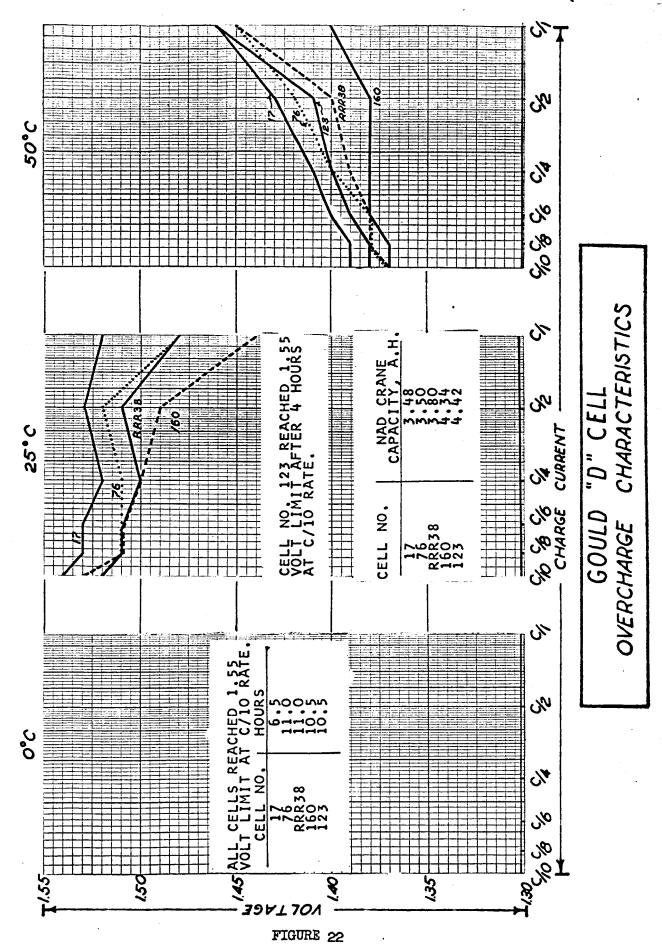
GOULD D-CELL NO. 160 NAD CRANE CAPACITY 4.34 A.H. CHARGE CURRENT . 70 A. (%), VOLTAGE LIMITED TO 150 V. PER CELL DISCHARGE CURRENT 175 A. (%), CUTOFF VOLTAGE 0.9 V.



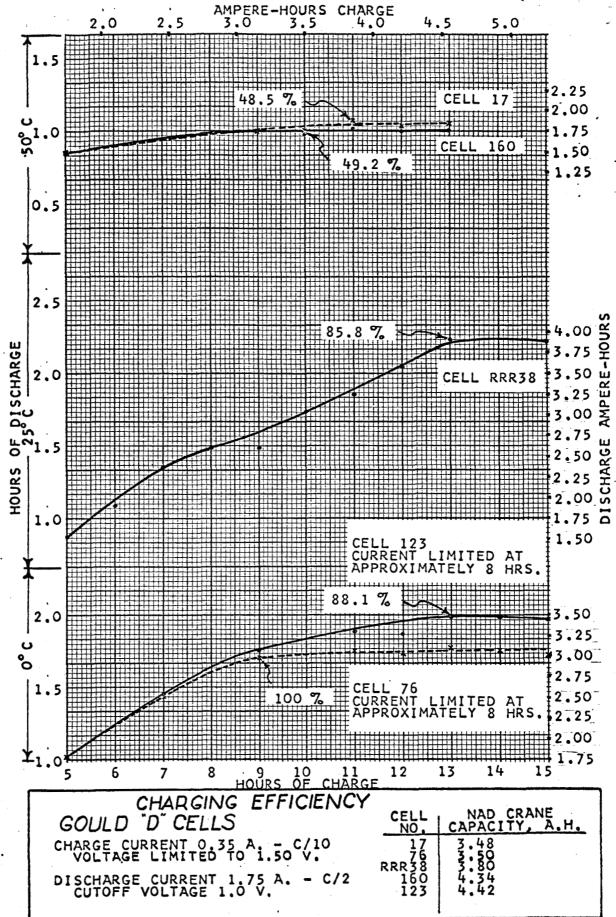
GOULD "D" CELLS

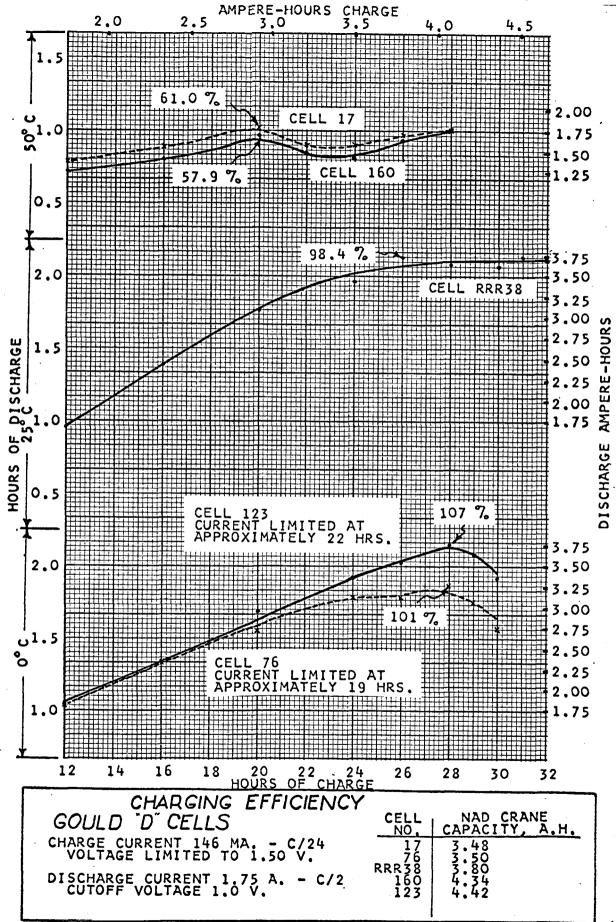
AVERAGE CELL OUTPUT VS TEMPERATURE (FROM FIGURES 1 THROUGH 20)

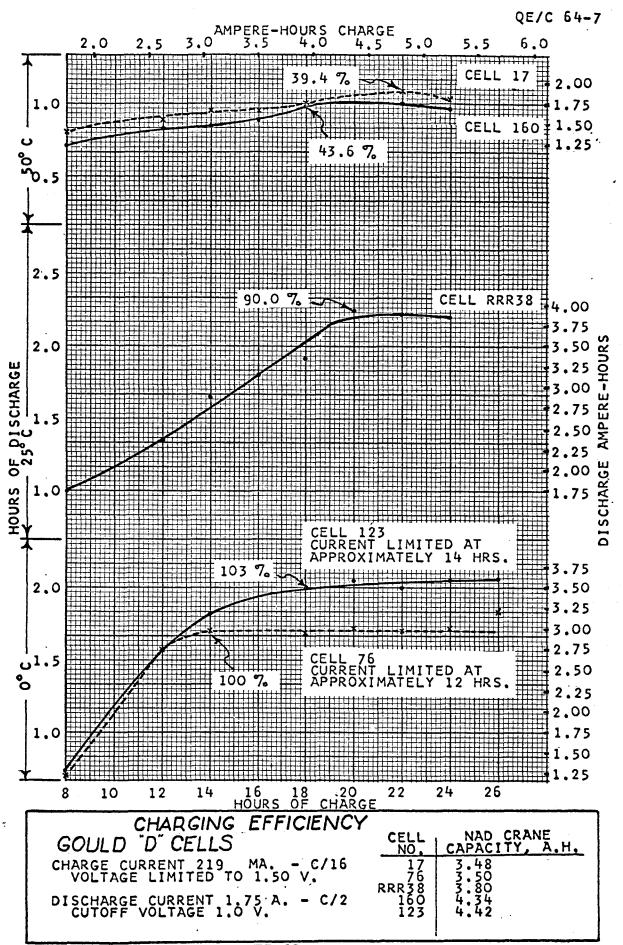
FIGURE 21

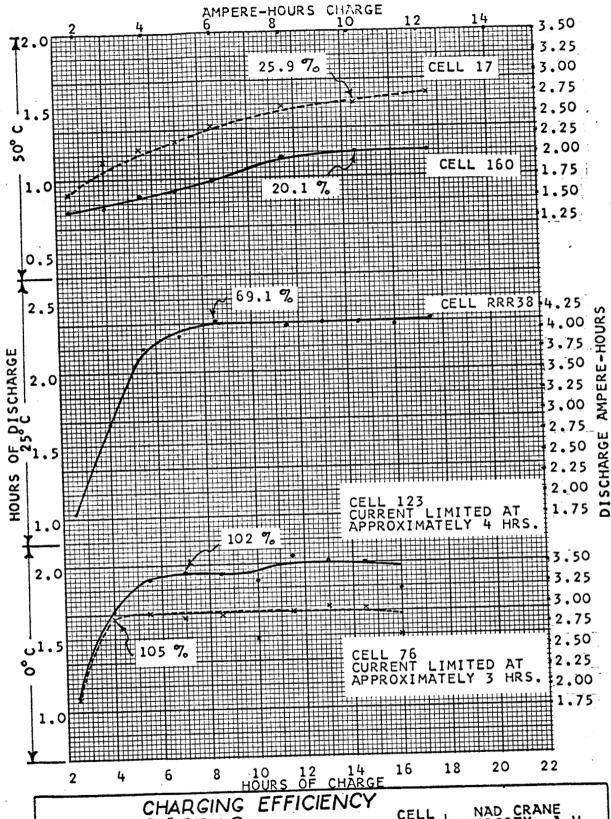


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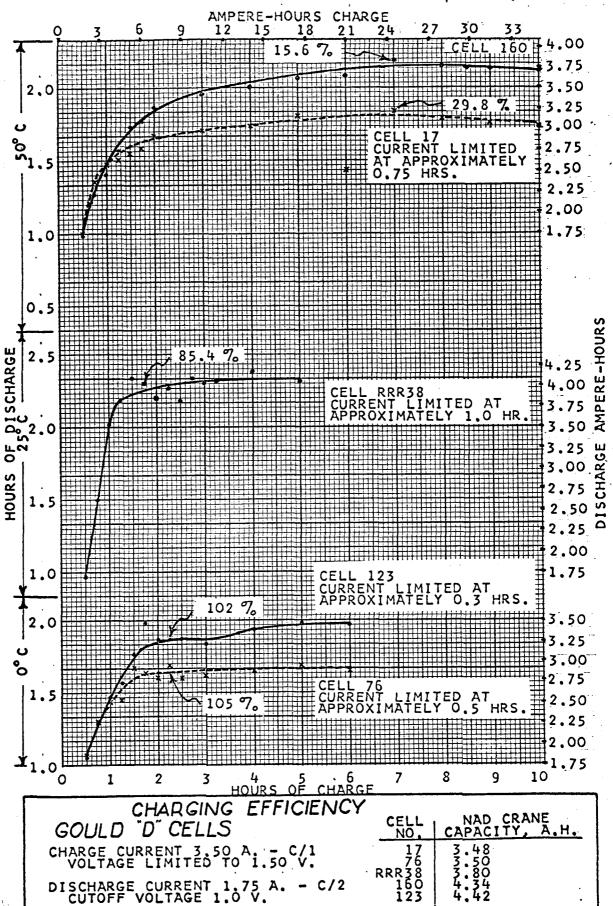








CHARGING EFFICIENCY GOULD "D" CELLS CHARGE CURRENT 0.70 A C/5 VOLTAGE LIMITED TO 1.50 V. DISCHARGE CURRENT 1.75 A C/2 CUTOFF VOLTAGE 1.0 V.	CELL NAD CRANE NO. CAPACITY, A.H. 17 3.48 76 3.50 RRR38 3.80 160 4.34 123 4.42	
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